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INFORMATION DISCLOSURE STATEMENT Applicant									
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	AD	4,506,238	03/1985	Endoh et al.	333	138		
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L.	AR	6,445,077	09/2002	Choi et al.	257	786		
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Form PTO-1	449		<del></del>		Atty Do	cket No.	Serial No.
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*Examiner Initial		Other Art (Including Author, Title, D	ate, Pertinent Pages	, Etc.)			
M	AA	U.S. Application Serial No. 09/865,367, filed May 24, 2001, entitled "Semiconductor Chip Assembly With Simultaneously Electroplated Contact Terminal and Connection Joint"					
M	AB	U.S. Application Serial No. 09/864,555, filed May 24, 2001, entitled "Semiconductor Chip Assembly with Simultaneously Electrolessly Plated Contact Terminal and Connection Joint"					
m	AC	U.S. Application Serial No. 09/864,773, filed May 24, 2001, entitled "Semiconductor Chip Assembly With Ball Bond Connection Joint"					
M	AD	U.S. Application Serial No. 09/878,649 filed June 11, 2001, entitled "M thod of Making a Semiconductor Chip Assembly with a Conductive Trace Subtractively Formed Before and After Chip Attachment"					
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M	AF	U.S. Application Serial No. 09/917,339 filed July 27, 2001, entitled "Method of Connecting a Bumped Compliant Conductive Trace to a Semiconductor Chip"					
M	AG	U.S. Application Serial No. 09/927,216 filed August 10, 2001, entitled "Semiconductor Chip Assembly with Hardened Connection Joint"					
M	AH	U.S. Application Serial No. 09/939,140 filed August 24, 2001, entitled "Semiconductor Chip Assembly with Interlocked Conductive Trace"					
M	AI	U.S. Application Serial No. 09/962,754 filed September 24, 2001, entitled "Method of Connecting a Conductive Trace and an Insulative Base to a Semiconductor Chip"					
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At	AK	U.S. Application Serial No. 09/997,973 f "Method of Connecting a Bumped Conductiv					
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